

SPECIFICATION

DEVICE NAME : Power MOSFET

TYPE NAME : 2SK2834-01

SPEC. No. :

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Fuji Electric Co., Ltd.
Matsumoto Factory

This Specification is subject to change without notice.

| | DATE | NAME | APPROVED | Fuji Electric Co., Ltd. | |
|---------|------|------|----------|-------------------------|------|
| DRAWN | | | | DWG. NO. | 1/12 |
| CHECKED | | | | | |
| | | | | | |

1. Scope
This specifies Fuji power MOSFET 2SK2834-01
2. Construction N-channel enhancement mode power MOSFET
3. Application for switching
4. Outview T0-3P Outview See to 5/12 page
5. Absolute maximum ratings at $T_c=25^\circ\text{C}$ (unless otherwise specified)

| Description | Symbol | Characteristics | Unit | |
|---|--------------|-----------------|------------------|---------------------------------|
| Drain-source voltage | V_{DS} | 600 | V | |
| Continuous Drain current | I_D | ± 9 | A | |
| Pulsed drain current | I_{Dpulse} | ± 32 | A | |
| Gate-source voltage | V_{GS} | ± 35 | V | |
| Repetitive or non-repetitive | I_{AR} | 9 | V | $T_{ch} \leq 150^\circ\text{C}$ |
| Avalanche energy | E_{AS} | 162.3 | mJ | See page 12/12 ※ |
| Maximum power dissipation | P_D | 80 | W | |
| Operating and storage temperature range | T_{ch} | 150 | $^\circ\text{C}$ | |
| | T_{sto} | -55 ~ +150 | $^\circ\text{C}$ | |

※ $L=3.67\text{mH}$, $V_{CC}=60\text{V}$

6. Electrical characteristics at $T_c=25^\circ\text{C}$ (unless otherwise specified)
- Static ratings

| Description | Symbol | Conditions | Characteristics | | | Unit |
|----------------------------------|--------------|---|------------------------------|------|------|---------------|
| | | | Min. | Typ. | Max. | |
| Drain-source breakdown voltage | $B V_{DSS}$ | $I_D = 1\text{mA}$ $V_{GS} = 0\text{V}$ | 600 | | | V |
| Gate threshold voltage | $V_{GS(th)}$ | $I_D = 1\text{mA}$ $V_{DS} = V_{GS}$ | 3.5 | 4.0 | 4.5 | V |
| Zero gate voltage drain current | I_{DSS} | $V_{DS} = 600\text{V}$ $V_{GS} = 0\text{V}$ | $T_{ch} = 25^\circ\text{C}$ | | | μA |
| | I_{DSS} | | $T_{ch} = 125^\circ\text{C}$ | | | mA |
| Gate-source leakage current | I_{GSS} | $V_{GS} = \pm 35\text{V}$ $V_{DS} = 0\text{V}$ | | 10 | 100 | nA |
| Drain-source on-state resistance | $R_{DS(on)}$ | $I_D = 4.5\text{A}$ $V_{GS} = 10\text{V}$ | | 1.0 | 1.2 | Ω |

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2/12

H04-004-03

Dynamic ratings

| Description | Symbol | Conditions | Characteristics | | | Unit |
|------------------------------|--------------|--|-----------------|------|------|------|
| | | | Min. | Typ. | Max. | |
| Forward transconductance | g_{fs} | $I_D = 4.5A$ $V_{DS} = 25V$ | 2.5 | 5.0 | | S |
| Input capacitance | C_{iss} | $V_{DS} = 25V$ $V_{GS} = 0V$ $f = 1MHz$ | | 900 | 1400 | pF |
| Output capacitance | C_{oss} | | | 150 | 230 | pF |
| Reverse transfer capacitance | C_{rss} | | | 70 | 110 | pF |
| Turn-on time | $t_{d(on)}$ | $V_{CC} = 300V$ $V_{GS} = 10V$ $I_D = 9A$ $R_{GS} = 10\Omega$ | | 25 | 40 | ns |
| | t_r | | | 70 | 110 | ns |
| Turn-off time | $t_{d(off)}$ | | | 60 | 90 | ns |
| | t_f | | | 35 | 60 | ns |

Reverse diode

| Description | Symbol | Conditions | Characteristics | | | Unit |
|--------------------------|----------|---|-----------------|------|------|------|
| | | | Min. | Typ. | Max. | |
| Avalanche capability | I_{AV} | $L = 3.67mH, T_{ch} = 25^\circ C$ *See Fig.1 and 2 | 9 | | | A |
| Diode forward on-voltage | V_{SD} | $I_F = 2 \times I_{DR}$ $V_{GS} = 0V, T_{ch} = 25^\circ C$ | | 1.0 | 1.5 | V |
| Reverse recovery time | t_{rr} | $I_F = I_{DR}$ $V_{GS} = 0V$ $-di_F/dt = 100A/\mu s$ $T_{ch} = 25^\circ C$ | | 550 | | ns |
| Reverse recovery charge | Q_{rr} | | | | 7.0 | |

7. Thermal resistance

| Description | Symbol | Conditions | Characteristics | | | Unit |
|--------------------|-----------------|------------|-----------------|------|------|--------------|
| | | | Min. | Typ. | Max. | |
| Thermal resistance | $R_{th_{ch-c}}$ | | | | 1.56 | $^\circ C/W$ |
| | $R_{th_{ch-a}}$ | | | | 35.0 | $^\circ C/W$ |

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Fig.1 Test circuit

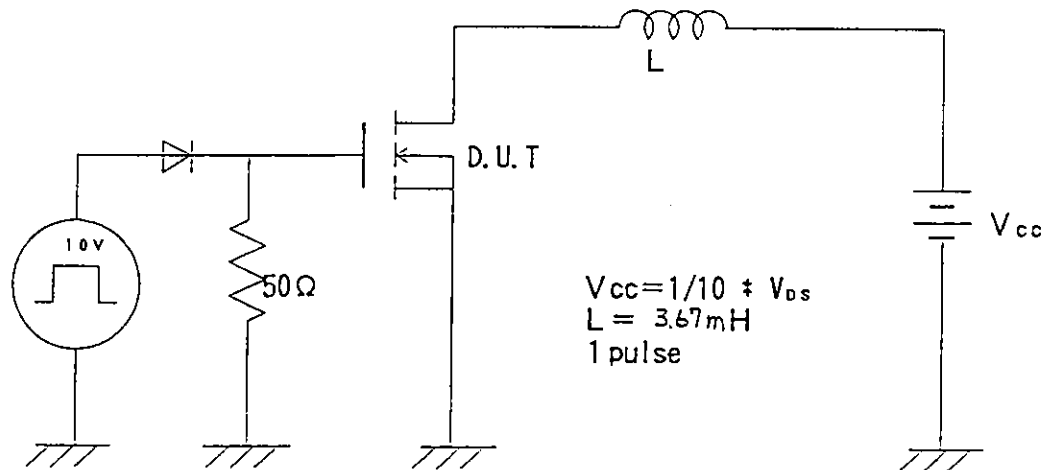
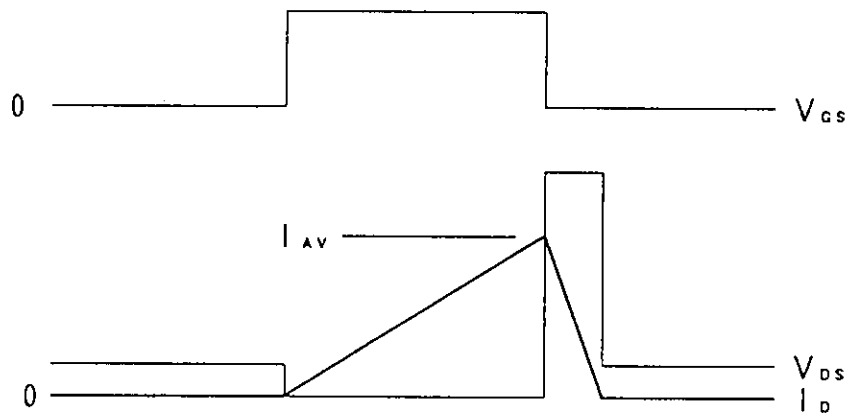
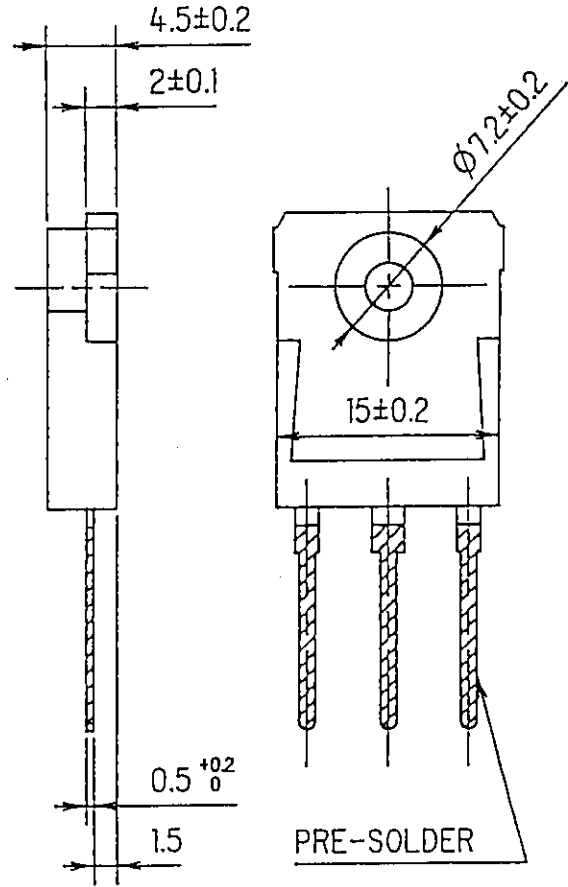
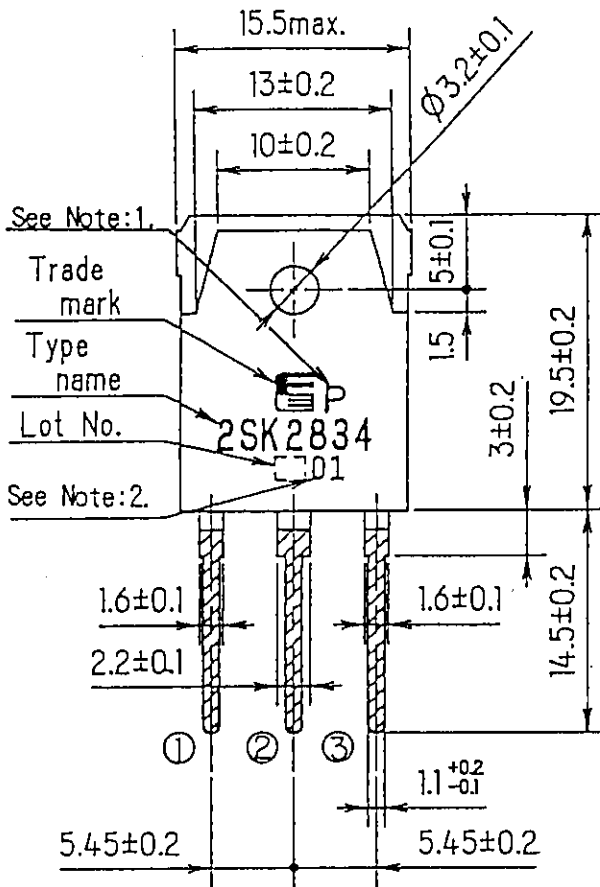


Fig.2 Operating waveforms

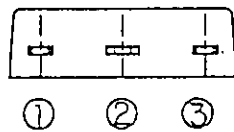


FUJI POWER MOS FET

TYPE : 2SK2834-01P



DIMENSIONS ARE IN MILLIMETERS.



CONNECTION

- ① GATE
- ② DRAIN
- ③ SOURCE

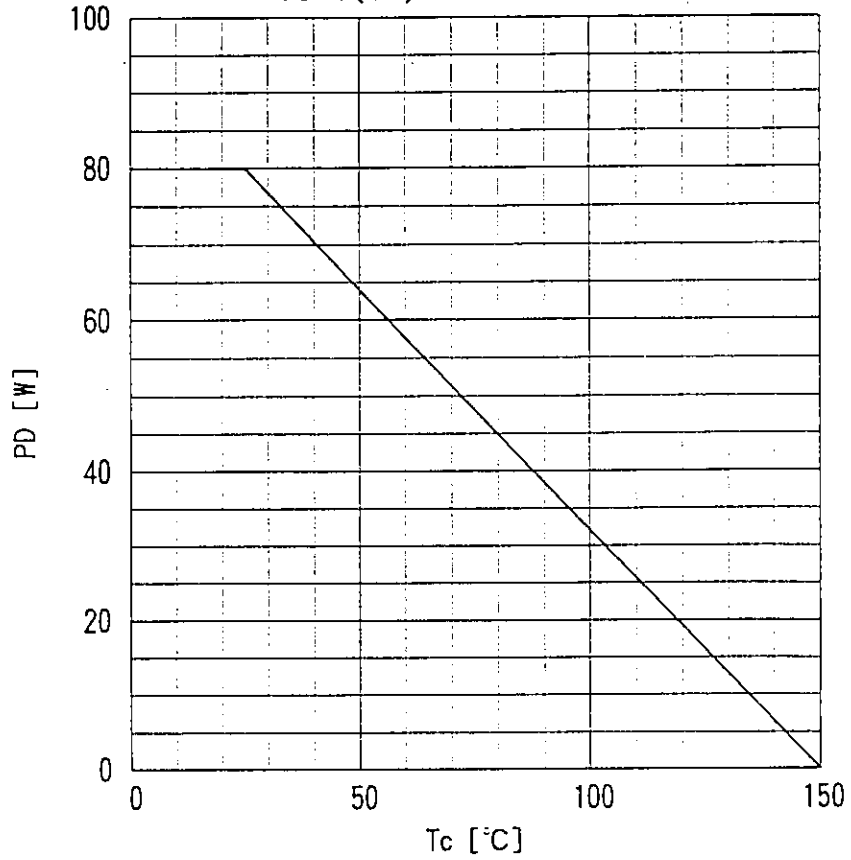
Note:1. Country of origin mark.
 No mark is Made in JAPAN
 「P」 is Made in PHILIPPINES.

2. Guaranteed mark of avalanche ruggedness.

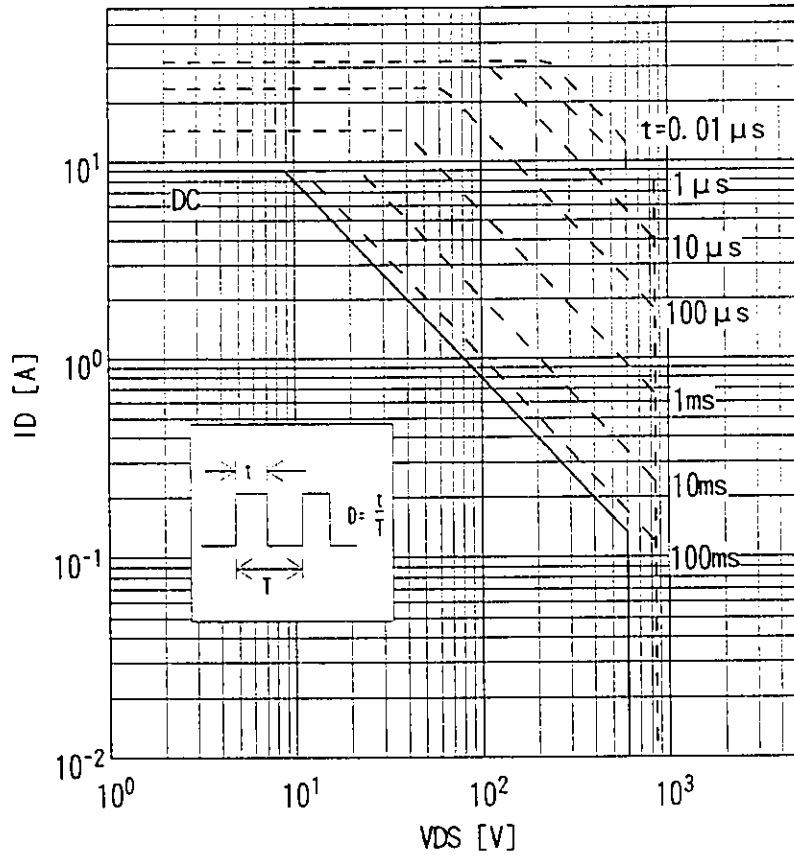
JEDEC : TO-247.
 EIAJ : SC-65

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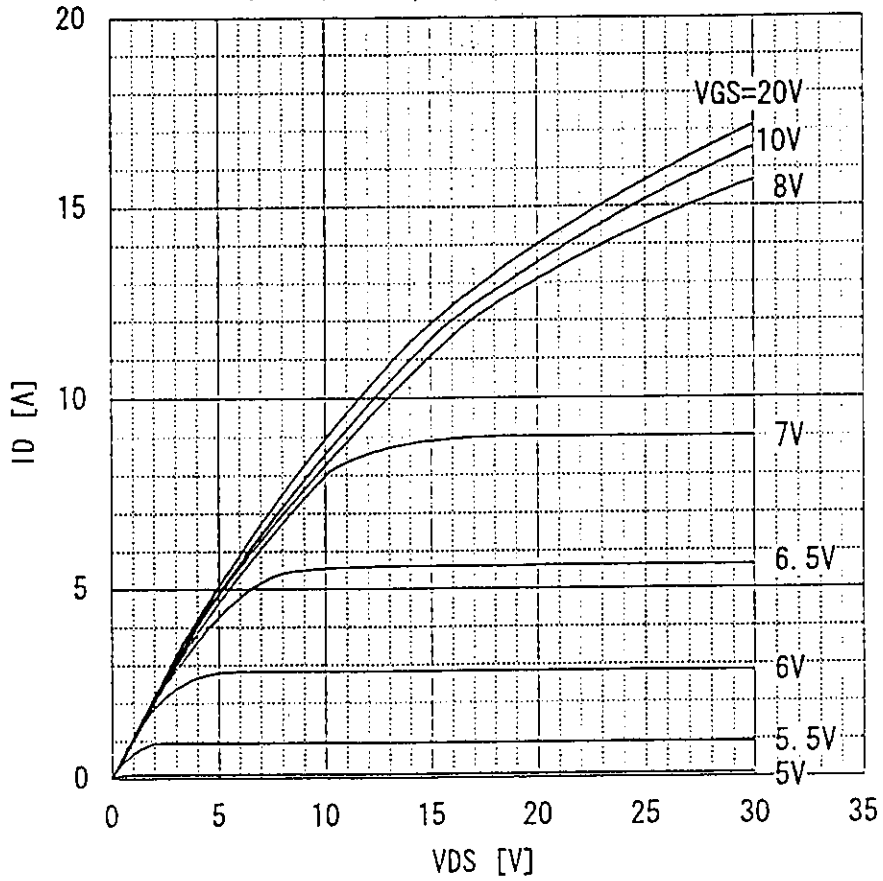
Power Dissipation
 $PD=f(T_c)$



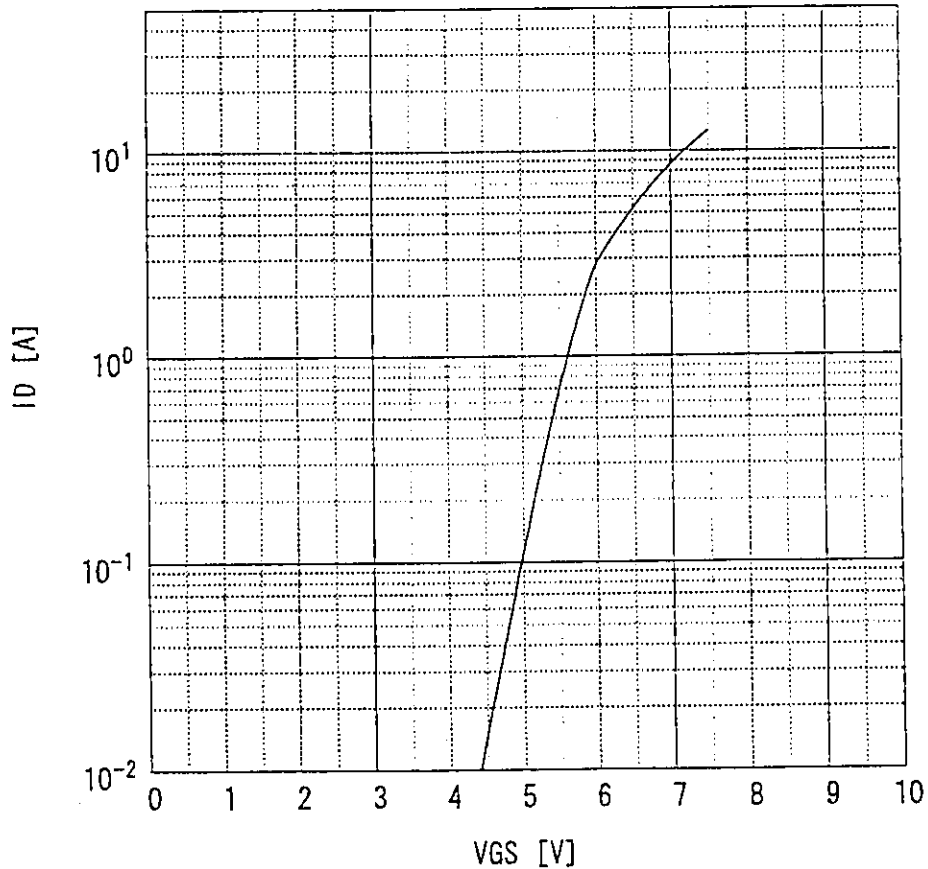
Safe operating area
 $ID=f(V_{DS}): D=0.01, T_c=25^\circ C$



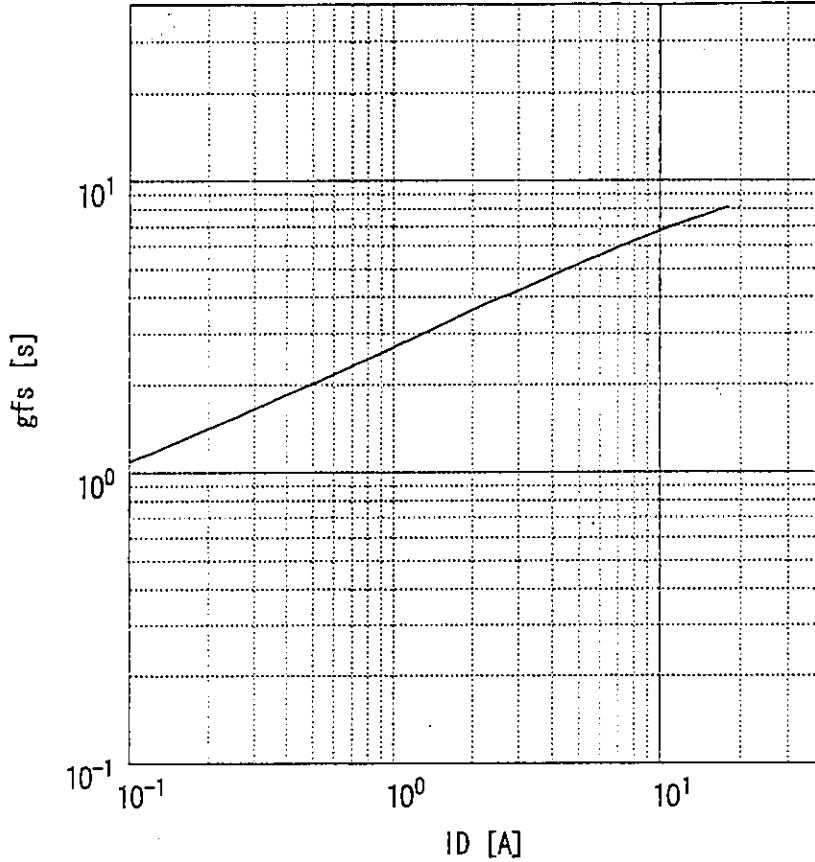
Typical output characteristics
 $I_D = f(V_{DS}) : 80 \mu s$ pulse test, $T_c = 25^\circ C$



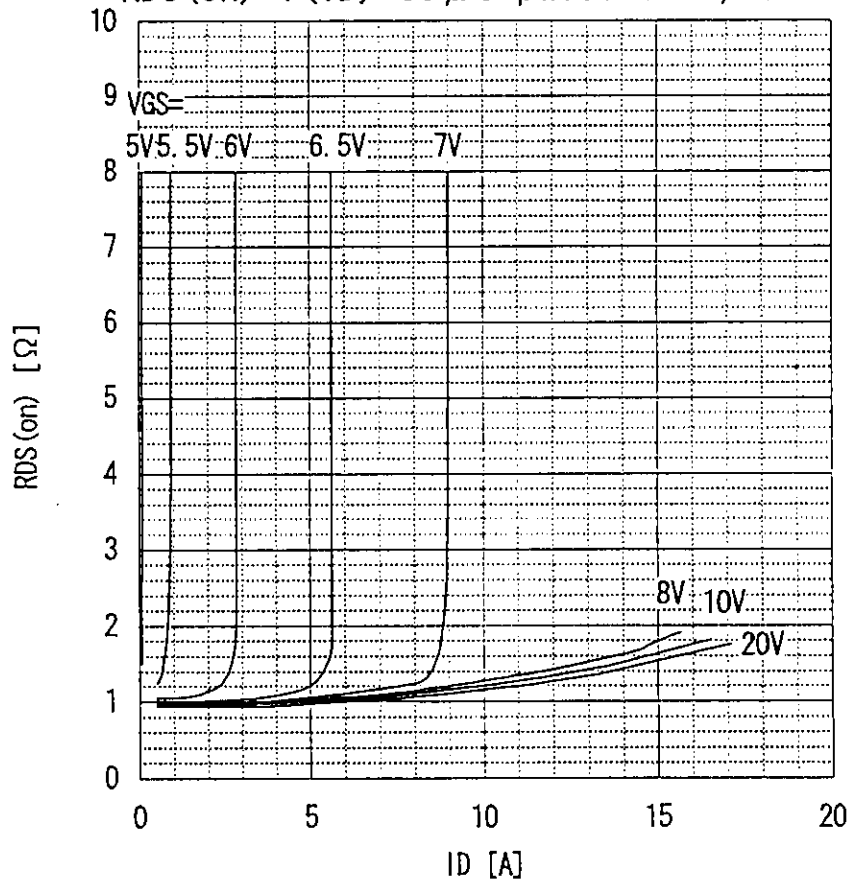
Typical transfer characteristic
 $I_D = f(V_{GS}) : 80 \mu s$ pulse test, $V_{DS} = 25V$, $T_{ch} = 25^\circ C$



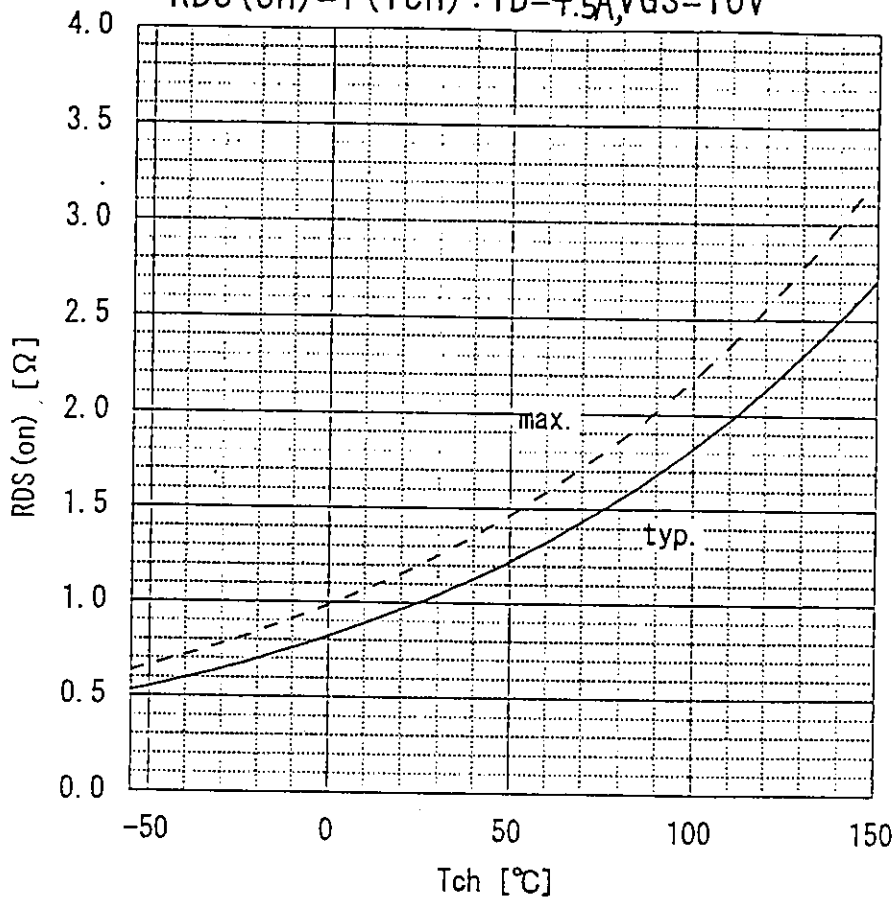
Typical forward transconductance
 $g_{fs}=f(I_D)$: 80 μ s pulse test, $V_{DS}=25V$, $T_{ch}=25^\circ C$



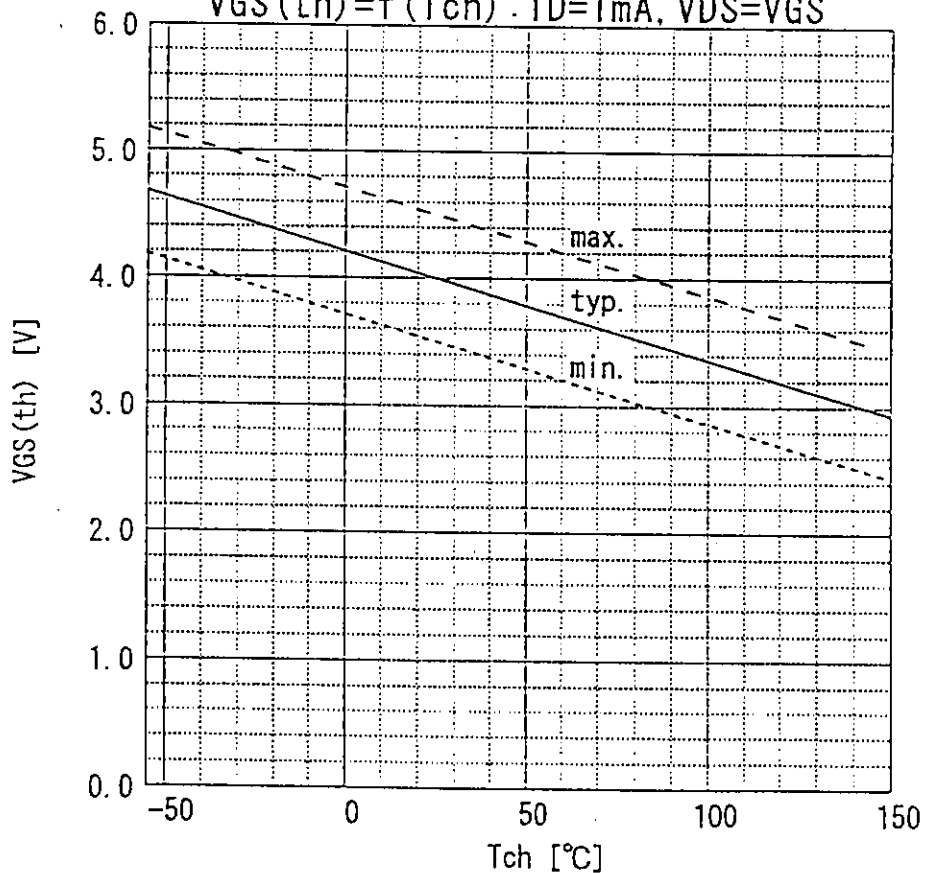
Typical drain-source on-state resistance
 $R_{DS(on)}=f(I_D)$: 80 μ s pulse test, $T_c=25^\circ C$



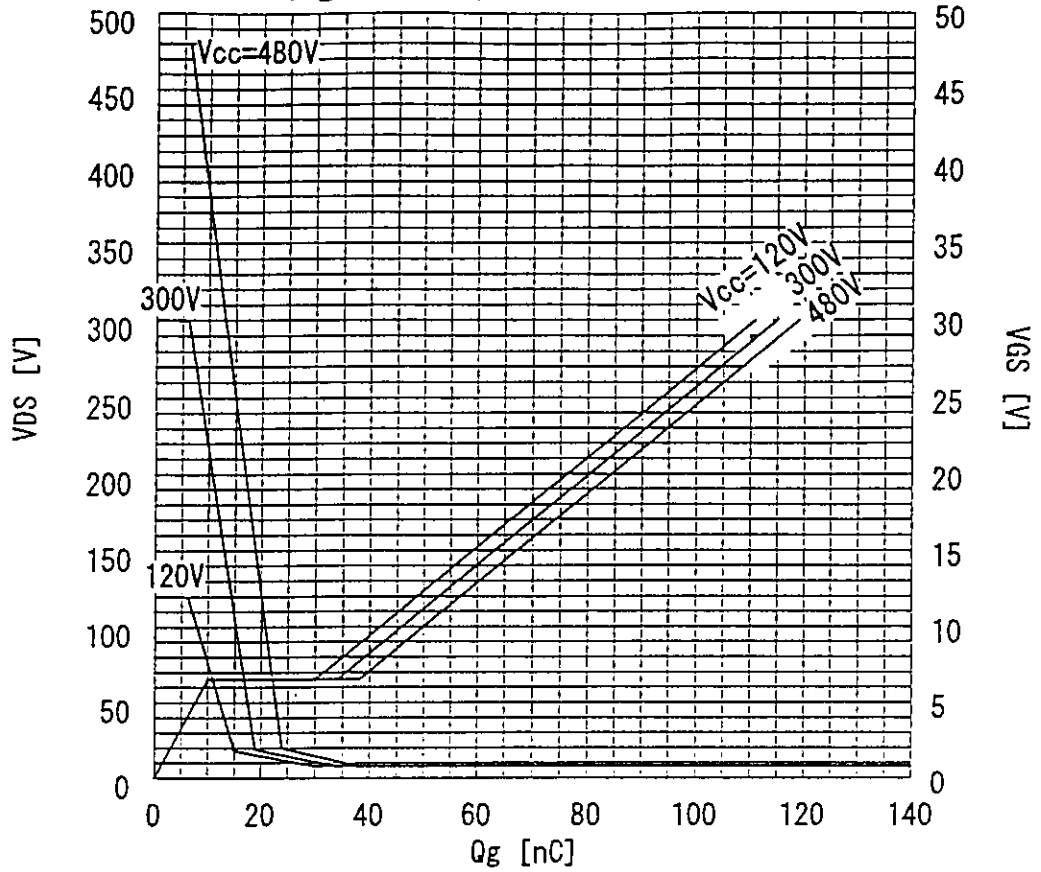
Drain-source on-state resistance
 $R_{DS(on)} = f(T_{ch}) : I_D = 4.5A, V_{GS} = 10V$



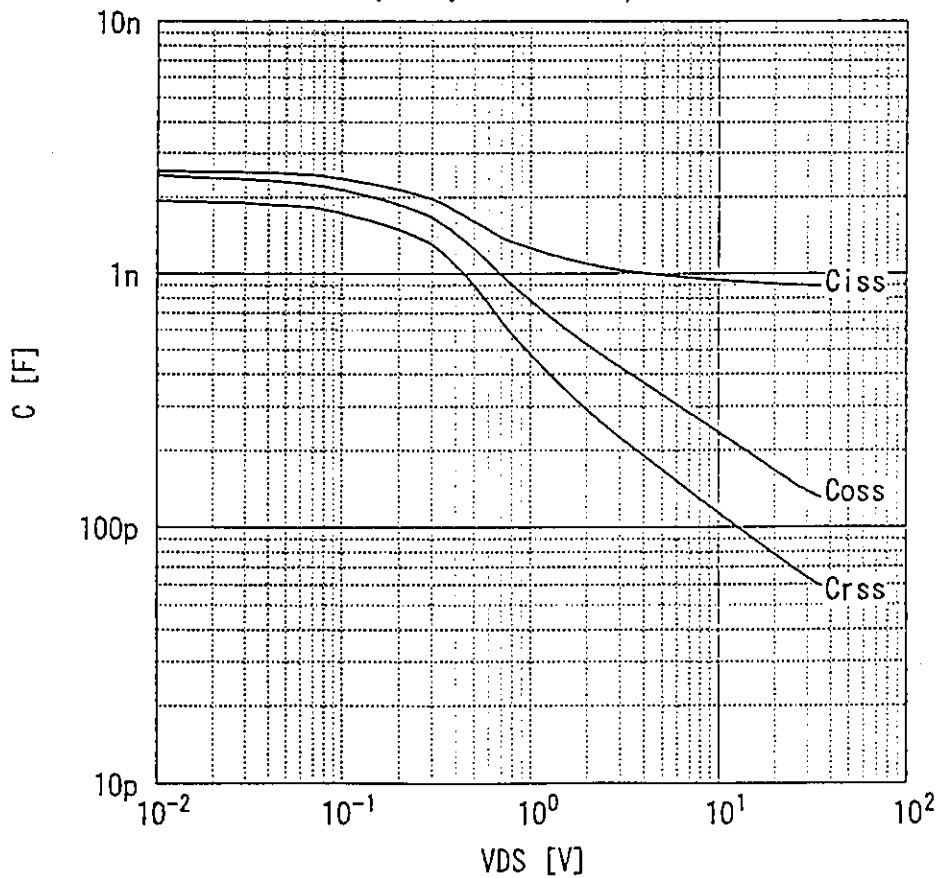
Gate threshold voltage
 $V_{GS(th)} = f(T_{ch}) : I_D = 1mA, V_{DS} = V_{GS}$



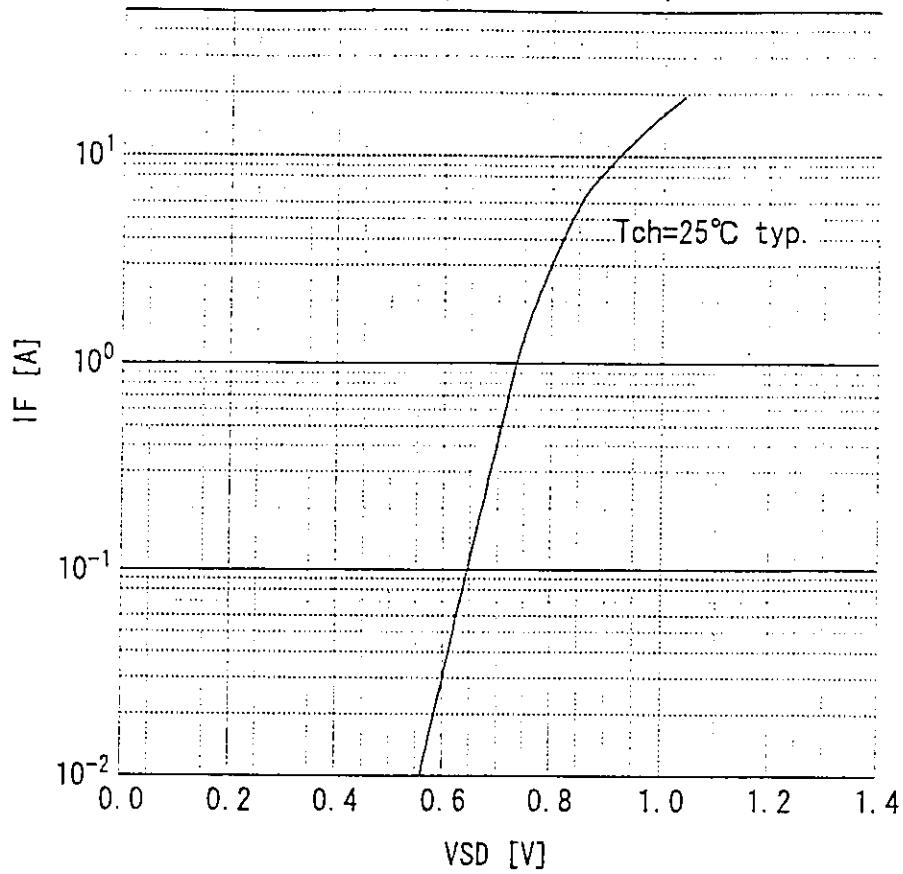
Typical gate charge characteristic
 $V_{GS}=f(Q_g) : I_D=9A, T_c=25^\circ C$



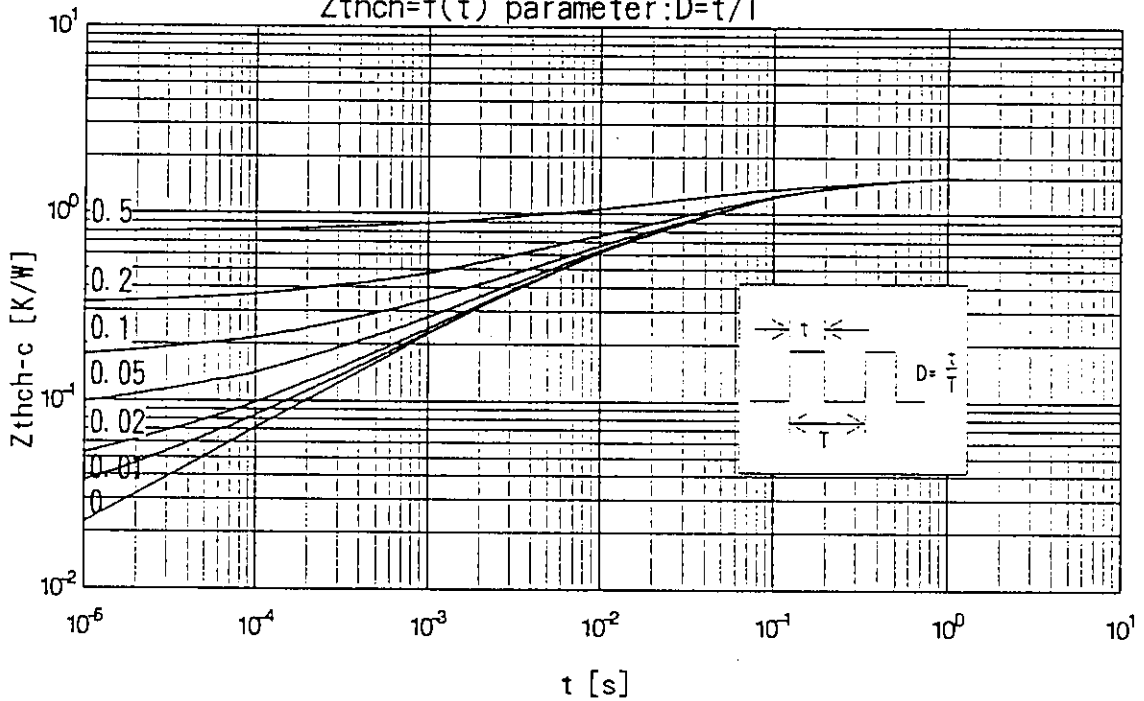
Typical capacitances
 $C=f(V_{DS}) : V_{GS}=0V, f=1MHz$



Forward characteristic of reverse of diode
 $I_F = f(V_{SD}) : 80 \mu s$ pulses test, $V_{GS} = 0V$

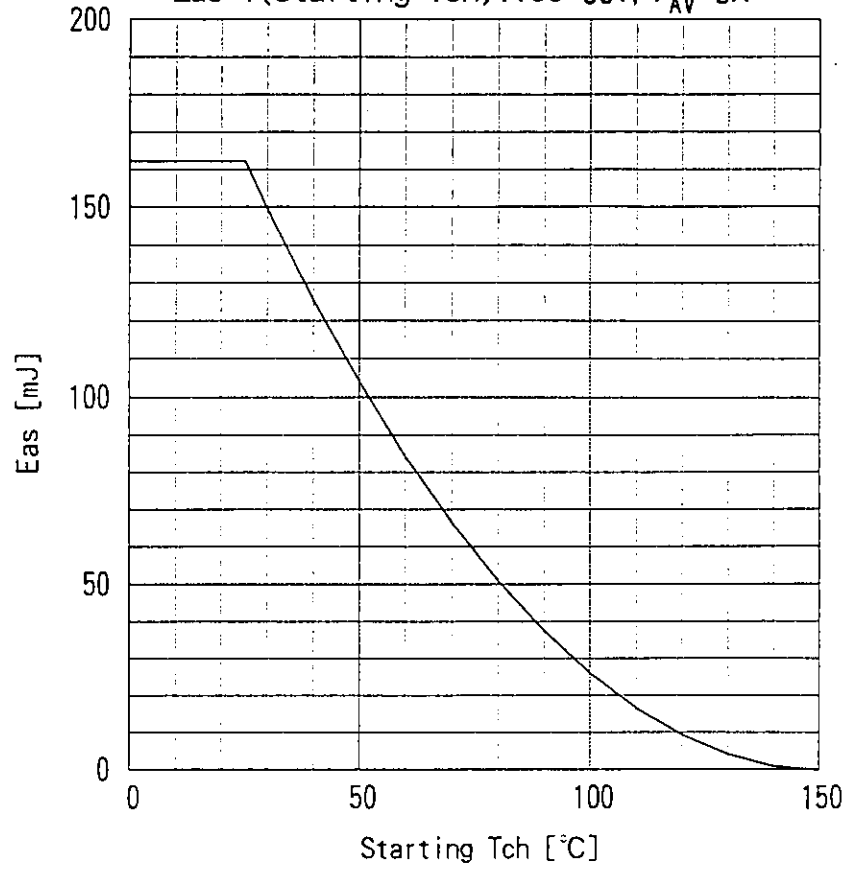


Transient thermal impedance
 $Z_{thch} = f(t)$ parameter: $D = t/T$



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Avalanche energy derating
 $E_{as} = f(\text{starting } T_{ch}) : V_{CC} = 60V, I_{AV} = 9A$



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